Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/084,609	DINERSTEIN ET AL.		
Examiner	Art Unit		
Y. Lee	2613		

	SEARCHED				
Class	Subclass	Date	Examiner		
375	240.01	5/12/2005	YL		
	240.16				
	240.24				
	240.26				
H04N	7/12				

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
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